

Notice of References Cited	Application/Control No. 10/721,191		Applicant(s)/Patent Under Reexamination ALTICE ET AL.	
	Examiner RICHARD M. BEMBEN		Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0285545	12-2007	Hsieh, Tzu-Chiang	348/294
*	B	US-2004/0041932	03-2004	Chao et al.	348/308
*	C	US-2004/0041930	03-2004	Chao et al.	348/294
*	D	US-2007/0018267	01-2007	Altice et al.	257/445
*	E	US-2005/0110093	05-2005	Altice et al.	257/359
*	F	US-7,332,786	02-2008	Altice et al.	257/445
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.